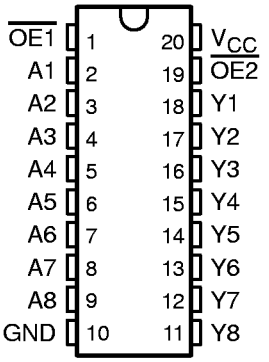
- **3-State Outputs Drive Bus Lines or Buffer Memory Address Registers**
- **Input Pullup Resistors Added for Data-Bus Termination**
- **Data Flow-Through Pinout (All Inputs on Opposite Side From Outputs)**
- **Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (N) 300-mil DIPs**

DW OR N PACKAGE
(TOP VIEW)



description

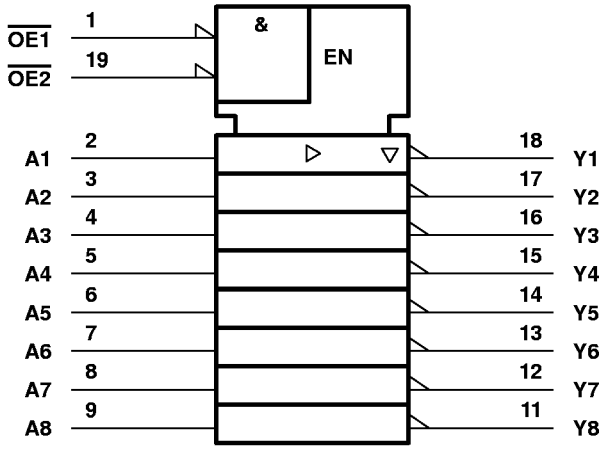
This octal buffer and line driver is designed to have the performance of the ALS240A and, at the same time, offers a pinout with inputs and outputs on opposite sides of the package. This arrangement facilitates printed-circuit-board layout. In addition, 20-kΩ resistors have been added between all inputs and V_{CC}. This eliminates adding external resistors in applications where the data bus must be at a high level when all other connecting devices are at a high-impedance state.

The 3-state control gate is a 2-input NOR such that if either output-enable ($\overline{OE1}$ or $\overline{OE2}$) input is high, all eight outputs are in the high-impedance state.

The SN74ALS746 provides inverted data at the outputs.

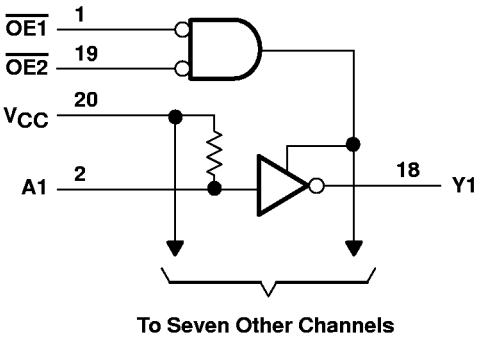
The SN74ALS746 is characterized for operation from 0°C to 70°C.

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



All input pullup resistors are 20 kΩ.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{CC} . . . . . 7 V
Input voltage, V_I . . . . . 7 V
Operating free-air temperature range, T_A . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
I_{OH}	High-level output current			−15	mA
I_{OL}	Low-level output current			24	mA
T_A	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP‡	MAX	UNIT
V_{IK}		V_{CC} = 4.5 V,	I_I = −18 mA			−1.2	V
V_{OH}		V_{CC} = 4.5 V to 5.5 V,	I_{OH} = −0.4 mA	V_{CC} −2			V
		V_{CC} = 4.5 V	I_{OH} = −3 mA	2.4	3.2		
			I_{OH} = −15 mA	2			
V_{OL}		V_{CC} = 4.5 V	I_{OL} = 12 mA		0.25	0.4	V
			I_{OL} = 24 mA		0.35	0.5	
I_{OZH}		V_{CC} = 5.5 V,	V_O = 2.7 V			20	µA
I_{OZL}		V_{CC} = 5.5 V,	V_O = 0.4 V			−20	µA
I_I	A	V_{CC} = 5.5 V	V_I = 5.5 V			0.1	mA
	$\overline{OE1}$, $\overline{OE2}$		V_I = 7 V			0.1	
I_{IH}	A	V_{CC} = 5.5 V,	V_I = 2.7 V			−0.2	mA
	$\overline{OE1}$, $\overline{OE2}$					20	µA
I_{IL}	A	V_{CC} = 5.5 V,	V_I = 0.4 V			−0.6	mA
	$\overline{OE1}$, $\overline{OE2}$					−0.1	
I_O§		V_{CC} = 5.5 V,	V_O = 2.25 V	−30		−112	mA
I_{CC}		V_{CC} = 5.5 V	Outputs high		7	12	mA
			Outputs low		13	22	
			Outputs disabled		11	19	

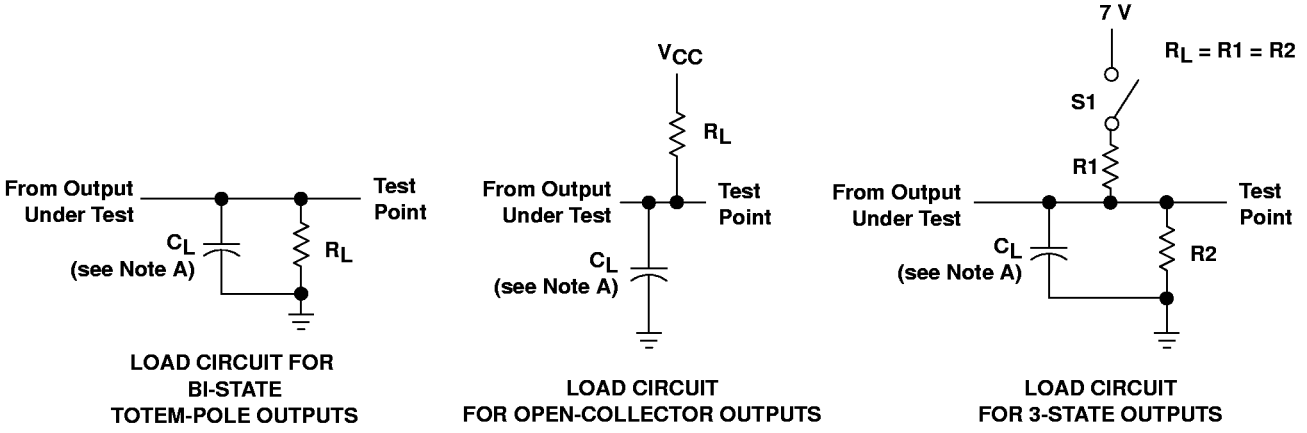
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_A = MIN to MAX†		UNIT
			MIN	MAX	
t_{PLH}	A	Y	3	12	ns
t_{PHL}			2	9	
t_{PZH}	$\overline{OE}$	Y	5	15	ns
t_{PZL}			8	20	
t_{PHZ}	$\overline{OE}$	Y	1	10	ns
t_{PLZ}			2	12	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

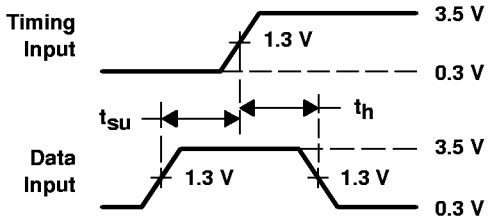
PARAMETER MEASUREMENT INFORMATION
SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



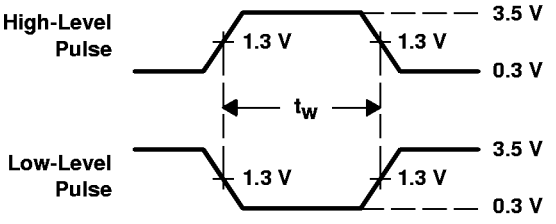
LOAD CIRCUIT FOR BI-STATE TOTEM-POLE OUTPUTS

LOAD CIRCUIT FOR OPEN-COLLECTOR OUTPUTS

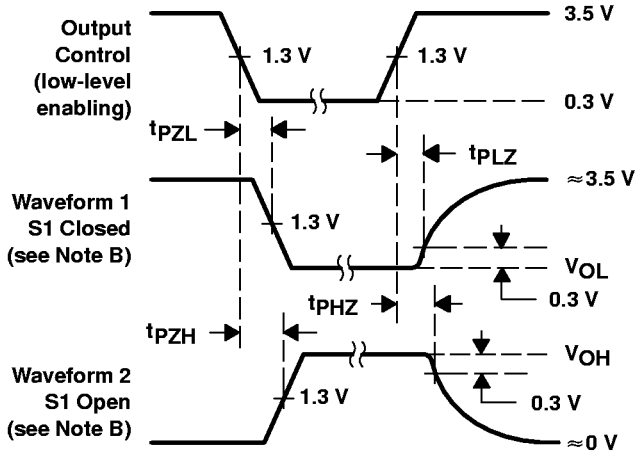
LOAD CIRCUIT FOR 3-STATE OUTPUTS



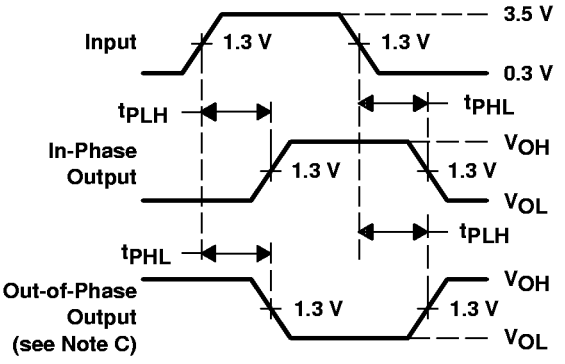
VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
PULSE DURATIONS



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES

NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
D. All input pulses have the following characteristics: PRR ≤ 1 MHz, $t_r = t_f$ = 2 ns, duty cycle = 50%.
E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

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MSP430F47127IPZ MSP430G2332IN20 OPA643P TCAN332DR TPS92200D2DDCR OPA2541BM SN75LV4735DBLE UCC27210DR TLC085CDR TLV990-28PFB TPS51125ARGER CC2520RHDR PCM56U SN74LVCZ240APW TPS71710DCKR UA9637ACPS ADS8344E BQ24314DSGR ISO124U/1K LMV358MMX/NOPB MSP430F2112TRHBT SN74GTL2006PWR TPA6203A1DRBR MSP430F2001TRSAT OPT3101RHFR MSP430G2403IPW28 DS90C383MTDX/NOPB MSP430F5131IDA MSP430F5172IRSBT TPS7A8018DRBR